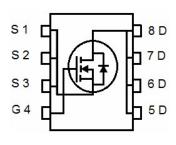


### **Description**

The AP050N03Q uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

## **Application**

- DC/DC Converter
- Ideal for high-frequency switching and synchronous rectification



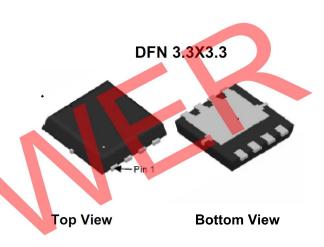
**Schematic Diagram** 

#### **General Features**

V<sub>DS</sub> =30V,I<sub>D</sub> =65

$$\begin{split} R_{DS(ON)} = &4.5 m\Omega \text{ (typical) } @ \text{ V}_{GS} = &10 \text{V} \\ R_{DS(ON)} = &6.5 m\Omega \text{ (typical) } @ \text{ V}_{GS} = &4.5 \text{V} \end{split}$$

- High density cell design for ultra low Rdson
- Very low on-resistance R<sub>DS(on)</sub>
- Good stability and uniformity with high E<sub>AS</sub>
- 150 °C operating temperature
- Pb-free lead plating



### Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
AP050N03Q	050N03Q	DFN 3.3X3.3-8L	-	-	-

#### Absolute Maximum Ratings (T<sub>c</sub>=25°Cunless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	30	V
Gate-Source Voltage	V <sub>G</sub> s	±20	V
Drain Current-Continuous	I <sub>D</sub>	65	А
Drain Current-Continuous(T <sub>C</sub> =100 °C)	I <sub>D</sub> (100℃)	46	Α
Pulsed Drain Current	I <sub>DM</sub>	260	Α
Maximum Power Dissipation	P <sub>D</sub>	45	W
Derating factor		0.36	W/℃
Single pulse avalanche energy (Note 5)	E <sub>AS</sub>	150	mJ
Operating Junction and Storage Temperature Range	$T_{J}, T_{STG}$	-55 To 150	$^{\circ}$

### **Thermal Characteristic**

Thermal Resistance, Junction-to-Case <sup>(Note 2)</sup>	$R_{ hetaJC}$	2.8	°C/W

# Electrical Characteristics (TC=25℃unless otherwise noted)

Parameter	Parameter Symbol Condition		Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	30	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =30V,V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA	1	1.5	2.2	٧
Drain-Source On-State Resistance	Б	V <sub>GS</sub> =10V, I <sub>D</sub> =20A	-	4.5	6.0	- mΩ
Dialif-Source Off-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A	-	6.5	8.5	
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =5V,I <sub>D</sub> =20A	30	-	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C <sub>Iss</sub>	V <sub>DS</sub> =15V,V <sub>GS</sub> =0V,	-	1784		PF
Output Capacitance	Coss	F=1.0MHz	-	266	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>	F-1.0MHZ	-	212		PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t <sub>d(on)</sub>			7		nS
Turn-on Rise Time	t <sub>r</sub>	$V_{DD}=5V$ , $I_{D}=20A$	-	6		nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =10 $V$ , $R_{GEN}$ =6 $\Omega$		30	=	nS
Turn-Off Fall Time	t <sub>f</sub>		_	8	-	nS
Total Gate Charge	Qg	V -15VI -20A	-	38.4	-	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}=15V, I_{D}=20A,$ $V_{GS}=10V$	-	5.8	-	nC
Gate-Drain Charge	$Q_{\mathrm{gd}}$	V <sub>GS</sub> - IOV	-	7.9	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =20A	-	0.85	1.2	٧
Diode Forward Current (Note 2)	Is		-	-	65	Α
Reverse Recovery Time	t <sub>rr</sub>	TJ = 25°C, I <sub>F</sub> = 20A	-	-	47	nS
Reverse Recovery Charge	Qrr	di/dt = 100A/µs <sup>(Note3)</sup>	-	-	25	nC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

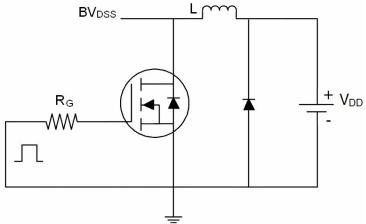
#### Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- **3.** Pulse Test: Pulse Width ≤  $300\mu$ s, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production
- **5.** EAS condition: Tj=25 $^{\circ}$ C,V<sub>DD</sub>=15V,V<sub>G</sub>=10V,L=0.5mH,Rg=25 $\Omega$

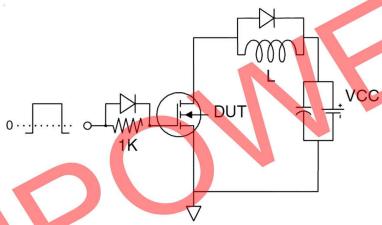


### **Test Circuit**

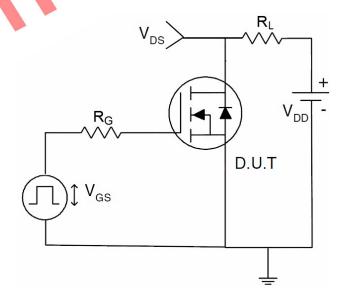
# 1) E<sub>AS</sub> Test Circuits



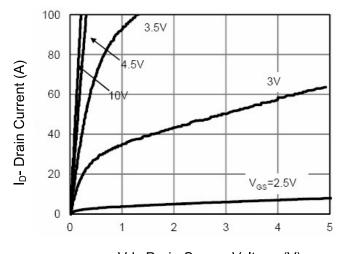
# 2) Gate Charge Test Circuit



# 3) Switch Time Test Circuit



### **Typical Electrical and Thermal Characteristics (Curves)**



Vds Drain-Source Voltage (V)

Figure 1 Output Characteristics

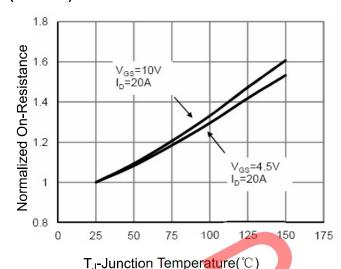
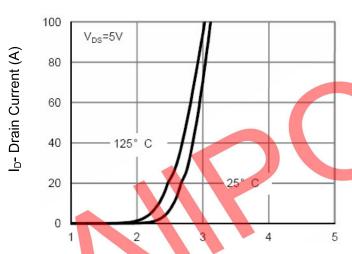
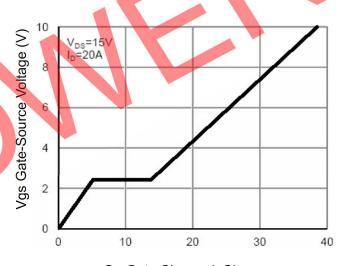


Figure 4 Rdson-Junction Temperature



Vgs Gate-Source Voltage (V)
Figure 2 Transfer Characteristics



Qg Gate Charge (nC)

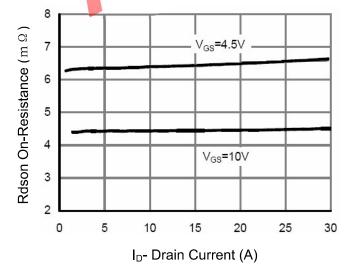


Figure 3 Rdson- Drain Current

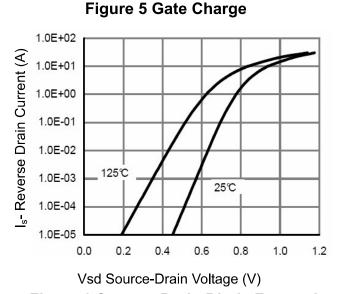
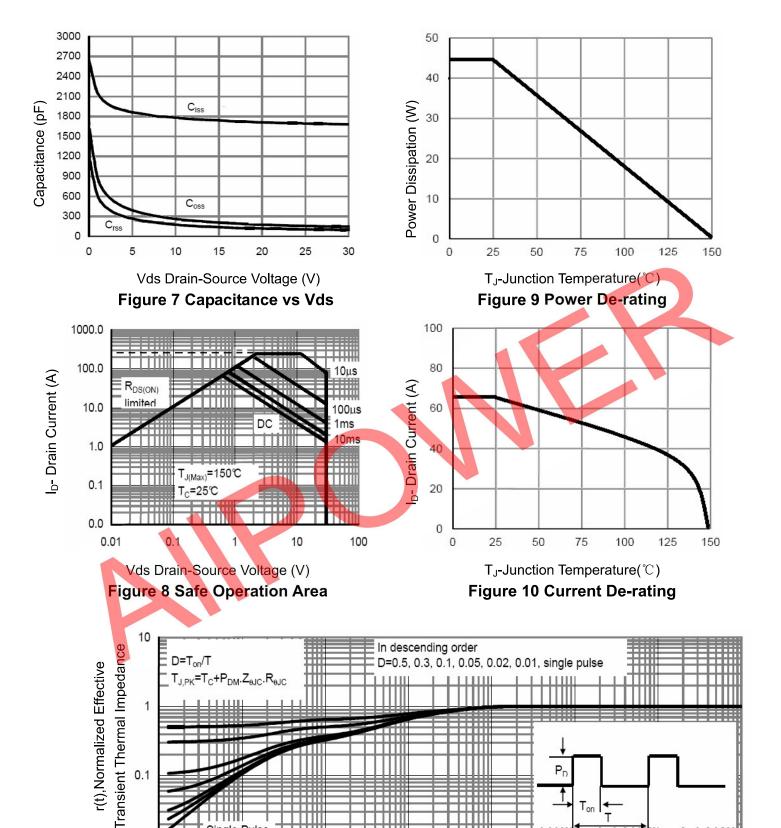


Figure 6 Source- Drain Diode Forward





**Figure 11 Normalized Maximum Transient Thermal Impedance** 

Square Wave Pluse Duration(sec)

0.01

0.1

0.01 0.00001 Single Pulse

0.0001

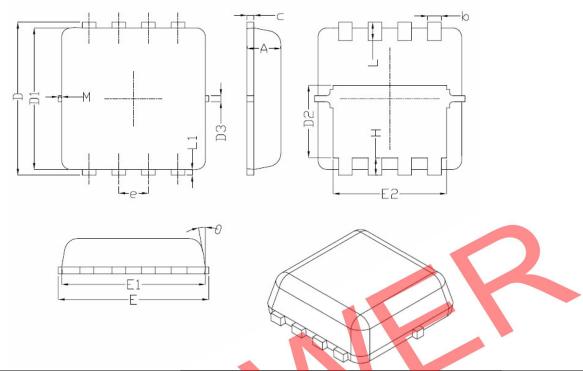
0.001

100

 $\mathsf{T}_{\mathsf{on}}$ 

10

# **DFN3.3X3.3-8L Package Information**



Symbol	Dimensions In Millimeters				
Symbol	Min.	Nom.	Max.		
А	0.70	0.75	0.80		
b	0.25	0.30	0.35		
С	0.10	0.15	0.25		
D	3.25	3.35	3.45		
D1	3.00	3.10	3.20		
D2	1.48	1.58	1.68		
D3	-	0.13	-		
E	3.20	3.30	3.40		
E1	3.00	3.15	3.20		
E2	2.39	2.49	2.59		
е	0.65BSC				
Н	0.30	0.39	0.50		
L	0.30	0.40	0.50		
L1	-	0.13	-		
M	*	*	0.15		
θ		10 <sup>°</sup>	12 <sup>°</sup>		